

# BZX 43 - BZX 44 - BZX 45

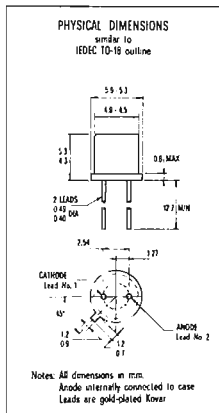
## VOLTAGE REFERENCE DIODES

SILICON PLANAR DIODES

**GENERAL DESCRIPTION** - These SGS - Silicon Planar Diodes are Temperature Compensated Voltage Reference elements designed for low power applications. Main features are low temperature coefficient over wide range of temperatures, low dynamic impedance at 100  $\mu$ A not obtainable with conventional voltage reference elements, low leakage at biases approaching the reference voltage. For applications where available power is quite low, these devices are exceptional in performances.

**ELECTRICAL CHARACTERISTICS** (25°C unless otherwise noted)

Reference Voltage	6.7 V
Voltage Tolerance	$\pm 5\%$
Operating Temperature	0°C to 100°C



**ELECTRICAL CHARACTERISTICS** (25°C unless otherwise noted)

SYMBOL	CHARACTERISTIC	MIN.	TYP.	MAX.	UNIT	TEST CONDITIONS
$V_Z$	Reference Voltage.....	6.3	6.6	7.03	V.....	$I_Z = 100 \mu A$
$I_R$	Reverse Leakage.....			100	nA.....	$V_R = 5 V$
$z_z$	Dynamic Impedance.....			750	$\Omega$ .....	$I_Z = 100 \mu A$
TC	Temperature Coefficient (BZX 43)..... (Note 1)			$\pm 0.001$	% /°C.....	$I_Z = 100 \mu A$ $T_C = 0^\circ C$ to $100^\circ C$
TC	Temperature Coefficient (BZX 44)..... (Note 1)			$\pm 0.002$	% /°C.....	$I_Z = 100 \mu A$ $T_C = 0^\circ C$ to $100^\circ C$
TC	Temperature Coefficient (BZX 45)..... (Note 1)			$\pm 0.005$	% /°C.....	$I_Z = 100 \mu A$ $T_C = 0^\circ C$ to $100^\circ C$

**NOTE :**  
 (1) Temperature coefficient is determined by measuring  $V_Z$  at the two temperature extremes and using the following formula.

$$TC = \frac{(V_{T1} - V_{T2}) 100}{V (T_1 - T_2)} \quad \text{where } V = \frac{(V_{T1} + V_{T2})}{2}$$